## Wavelength conversion in the Ta<sub>2</sub>O<sub>5</sub> based submicron channel waveguide

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Four-wave-mixing in optical communication region has been successfully demonstrated by using the Ta<sub>2</sub>O<sub>5</sub> based submicron channel waveguide. The geometrical dimension of Ta<sub>2</sub>O<sub>5</sub> core is 700×400 nm<sup>2</sup>. The ultra-low propagation loss of 1.5 dB/cm in the Ta<sub>2</sub>O<sub>5</sub> based channel waveguide enables the high power propagating in the core layer. Based on the continuous wave pump-probe measurement at pump/probe wavelengths of 1555.373/1556.08 nm, the converted signals of 1554.667/1556.787 nm via FWM processing in the Ta<sub>2</sub>O<sub>5</sub> based channel waveguide are observed. The conversion efficiency of -49 dB is determined, and the calculated nonlinear refractive index is  $1.5\pm0.6\times10^{-14}$  cm<sup>2</sup>/W at ~1550 nm. Our primarily results indicate that the nonlinear optical property of Ta<sub>2</sub>O<sub>5</sub> is comparable to Si<sub>3</sub>N<sub>4</sub>, and shows great potentials in the nonlinear waveguide applications.